

CMOS Low Voltage 2.5 Ω SPDT Switch In SC70 Package

ADG749

FEATURES

1.8 V to 5.5 V Single Supply 5 Ω (Max) On Resistance 0.75 Ω (Typ) On-Resistance Flatness –3 dB Bandwidth >200 MHz Rail-to-Rail Operation 6-Lead SC70 Package Fast Switching Times t_{ON} 20 ns t_{OFF} 6 ns

APPLICATIONS

TTL/CMOS-Compatible

Battery-Powered Systems
Communication Systems
Sample Hold Systems
Audio Signal Routing
Video Switching
Mechanical Reed Relay Replacement

Typical Power Consumption (<0.01 μW)

GENERAL DESCRIPTION

The ADG749 is a monolithic CMOS SPDT switch. This switch is designed on a submicron process that provides low power dissipation yet gives high switching speed, low on resistance and low leakage currents.

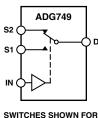
The ADG749 can operate from a single supply range of 1.8 V to 5.5 V, making it ideal for use in battery-powered instruments and with the new generation of DACs and ADCs from Analog Devices.

Each switch of the ADG749 conducts equally well in both directions when on. The ADG749 exhibits break-before-make switching action.

Because of the advanced submicron process, -3 dB bandwidths of greater than 200 MHz can be achieved.

The ADG749 is available in a 6-lead SC70 package.

FUNCTIONAL BLOCK DIAGRAM



SWITCHES SHOWN FOR A LOGIC "1" INPUT

PRODUCT HIGHLIGHTS

- 1. 1.8 V to 5.5 V Single Supply Operation. The ADG749 offers high performance, including low on resistance and fast switching times, and is fully specified and guaranteed with 3 V and 5 V supply rails.
- 2. Very Low R_{ON} (5 Ω max at 5 V, 10 Ω max at 3 V). At 1.8 V operation, R_{ON} is typically 40 Ω over the temperature range.
- 3. On-Resistance Flatness ($R_{FLAT(ON)}$) (0.75 Ω typ).
- 4. −3 dB Bandwidth >200 MHz.
- Low Power Dissipation. CMOS construction ensures low power dissipation.
- Fast t_{ON}/t_{OFF}.
- 7. Tiny 6-lead SC70 package.

$\label{eq:ADG749} \textbf{ADG749-SPECIFICATIONS}^{1} \ \ \substack{(V_{DD} = 5 \ V \ \pm \ 10\%, \ \text{GND} = 0 \ V. \ \text{All specifications} \ -40^{\circ}\text{C} \ \text{to} \ +85^{\circ}\text{C}, \ \text{unless otherwise} \ \\ \text{noted.})$

	B Version				
Parameter	25°C	-40°C to +85°C	Unit	Test Conditions/Comments	
ANALOG SWITCH					
Analog Signal Range		0 V to V _{DD}	V		
On Resistance (R _{ON})	2 .5	The state of the s	Ω typ	$V_S = 0 \text{ V to } V_{DD}, I_S = -10 \text{ mA}$	
olv	5	6	Ω max	Test Circuit 1	
On Resistance Match Between					
Channels (ΔR_{ON})		0.1	Ω typ	$V_{S} = 0 \text{ V to } V_{DD}, I_{S} = -10 \text{ mA}$	
		0.8	Ω max		
On-Resistance Flatness (R _{FLAT(ON)})	0.75		Ω typ	$V_S = 0 \text{ V to } V_{DD}, I_S = -10 \text{ mA}$	
(1211(611))		1.2	Ω max	225	
LEAKAGE CURRENTS ²				V _{DD} = 5.5 V	
Source OFF Leakage I _S (OFF)	±0.01		nA typ	$V_S = 4.5 \text{ V/1 V}, V_D = 1 \text{ V/4.5 V}$	
	±0.25	±0.35	nA max	Test Circuit 2	
Channel ON Leakage ID, IS (ON)	±0.01		nA typ	$V_S = V_D = 1 \text{ V}, \text{ or } V_S = V_D = 4.5 \text{ V}$	
	±0.25	±0.35	nA max	Test Circuit 3	
DIGITAL INPUTS					
Input High Voltage, V _{INH}		2.4	V min		
Input Low Voltage, V _{INI}		0.8	V max		
Input Current			,		
I _{INL} or I _{INH}	0.005		μA typ	$V_{IN} = V_{INI}$ or V_{INH}	
-INLINH		±0.1	μA max	· IN · INL · INH	
DYNAMIC CHARACTERISTICS ²					
t_{ON}	14		ns typ	$R_L = 300 \Omega, C_L = 35 pF$	
		20	ns max	$V_S = 3 \text{ V, Test Circuit 4}$	
$t_{ m OFF}$	3	_,	ns typ	$R_L = 300 \Omega$, $C_L = 35 pF$	
-011		6	ns max	$V_S = 3 \text{ V}$, Test Circuit 4	
Break-Before-Make Time Delay, t _D	8		ns typ	$R_L = 300 \Omega, C_L = 35 pF,$	
Į, D		1	ns min	$V_{S1} = V_{S2} = 3 \text{ V}$, Test Circuit 5	
Off Isolation	-67		dB typ	$R_L = 50 \Omega$, $C_L = 5 pF$, $f = 10 MHz$	
	-87		dB typ	$R_{L} = 50 \Omega, C_{L} = 5 pF, f = 1 MHz,$	
				Test Circuit 6	
Channel-to-Channel Crosstalk	-62		dB typ	$R_L = 50 \Omega, C_L = 5 pF, f = 10 MHz$	
	-82		dB typ	$R_L = 50 \Omega, C_L = 5 pF, f = 1 MHz,$	
			31	Test Circuit 7	
Bandwidth -3 dB	200		MHz typ	$R_L = 50 \Omega$, $C_L = 5 pF$, Test Circuit 8	
$C_{S}(OFF)$	7		pF typ		
$C_D, C_S(ON)$	27		pF typ		
POWER REQUIREMENTS				V _{DD} = 5.5 V	
				Digital Inputs = 0 V or 5 V	
I_{DD}	0.001		μA typ		
		1.0	μA max		

NOTES

Specifications subject to change without notice.

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¹Temperature ranges are as follows: B Version, -40°C to +85°C.

²Guaranteed by design, not subject to production test.

$\label{eq:continuous} \textbf{SPECIFICATIONS}^{1}(v_{DD}=3~v~\pm~10\%,~\text{GND}=0~v.~\text{All specifications}~-40^{\circ}\text{C to}~+85^{\circ}\text{C},~\text{unless otherwise noted.})$

	B Version				
Parameter	25°C	− 40°C to +85°C	Unit	Test Conditions/Comments	
ANALOG SWITCH					
Analog Signal Range		$0~\mathrm{V}$ to V_{DD}	V		
On Resistance (R _{ON})	6	7	Ω typ	$V_{S} = 0 \text{ V to } V_{DD}, I_{S} = -10 \text{ mA},$	
		10	Ω max	Test Circuit 1	
On Resistance Match Between			_		
Channels (ΔR_{ON})		0.1	Ω typ	$V_S = 0 \text{ V to } V_{DD}, I_S = -10 \text{ mA}$	
On Bosistanos Flatnoss (B.		0.8	Ω max	V = 0 V to V I = 10 m A	
On-Resistance Flatness (R _{FLAT(ON)})		2.5	Ω typ	$V_S = 0 \text{ V to } V_{DD}, I_S = -10 \text{ mA}$	
LEAKAGE CURRENTS ²				$V_{\rm DD}$ = 3.3 V	
Source OFF Leakage I _S (OFF)	±0.01		nA typ	$V_S = 3 \text{ V/1 V}, V_D = 1 \text{ V/3 V},$	
	±0.25	± 0.35	nA max	Test Circuit 2	
Channel ON Leakage I _D , I _S (ON)	±0.01	10.25	nA typ	$V_S = V_D = 1 \text{ V}, \text{ or } V_S = V_D = 3 \text{ V},$	
	±0.25	±0.35	nA max	Test Circuit 3	
DIGITAL INPUTS					
Input High Voltage, V _{INH}		2.0	V min		
Input Low Voltage, V _{INL}		0.4	V max		
Input Current	0.005		A .	37 - 37 37	
I_{INL} or I_{INH}	0.005	±0.1	μA typ	$V_{IN} = V_{INL}$ or V_{INH}	
		±0.1	μA max		
DYNAMIC CHARACTERISTICS ²					
t_{ON}	16	2.4	ns typ	$R_L = 300 \Omega$, $C_L = 35 pF$	
	4	24	ns max	$V_S = 2 \text{ V}$, Test Circuit 4	
$t_{ m OFF}$	4	7	ns typ ns max	$R_L = 300 \Omega$, $C_L = 35 pF$ $V_S = 2 V$, Test Circuit 4	
Break-Before-Make Time Delay, t _D	8	1	ns typ	$R_L = 300 \Omega$, $C_L = 35 pF$	
Break Before Wake Time Belay, to		1	ns min	$V_{S1} = V_{S2} = 2 \text{ V}, \text{ Test Circuit 5}$	
Off Isolation	-67	-	dB typ	$R_L = 50 \Omega$, $C_L = 5 pF$, $f = 10 MHz$	
	-87		dB typ	$R_L = 50 \Omega, C_L = 5 pF, f = 1 MHz,$	
				Test Circuit 6	
Channel-to-Channel Crosstalk	-62		dB typ	$R_L = 50 \Omega, C_L = 5 pF, f = 10 MHz$	
	-82		dB typ	$R_L = 50 \Omega$, $C_L = 5 pF$, $f = 1 MHz$,	
D 1 111 0 1D	200		1.77-	Test Circuit 7	
Bandwidth –3 dB	200		MHz typ	$R_L = 50 \Omega$, $C_L = 5 pF$, Test Circuit 8	
$C_{\rm S}$ (OFF)	7 27		pF typ		
C_D , C_S (ON)	21		pF typ		
POWER REQUIREMENTS				$V_{DD} = 3.3 \text{ V}$	
т	0.001			Digital Inputs = 0 V or 3 V	
$I_{ m DD}$	0.001	1.0	μA typ		
		1.0	μA max		

NOTES

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¹Temperature ranges are as follows: B Version, -40°C to +85°C.

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ADG749

ABSOLUTE MAXIMUM RATINGS1

$(T_A = 25^{\circ}C \text{ unless otherwise noted})$
V_{DD} to GND
Analog, Digital Inputs ² $-0.3 \text{ V to V}_{DD} + 0.3 \text{ V or}$
30 mA, Whichever Occurs First
Peak Current, S or D
(Pulsed at 1 ms, 10% Duty Cycle max)
Continuous Current, S or D
Operating Temperature Range
Industrial (B Version)40°C to +85°C
Storage Temperature Range65°C to +150°C
Junction Temperature
SC70 Package, Power Dissipation
θ_{JA} Thermal Impedance
θ_{JC} Thermal Impedance
Lead Temperature, Soldering
Vapor Phase (60 sec)
Infrared (15 sec)
ESD

NOTES

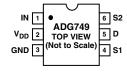
Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Only one absolute maximum rating may be applied at any one time.

²Overvoltages at IN, S or D will be clamped by internal diodes. Current should be limited to the maximum ratings given.

Table I. Truth Table

ADG749 IN	Switch S1	Switch S2	
0	ON	OFF	
1	OFF	ON	

PIN CONFIGURATION 6-Lead SC70



TERMINOLOGY

Most Positive Power Supply Potential.

Ground (0 V) Reference.
Source Terminal. May be an input or output.
Drain Terminal. May be an input or output.
Logic Control Input.
Ohmic resistance between D and S.
On resistance match between any two channels i.e., R_{ON} max – R_{ON} min.
Flatness is defined as the difference between the maximum and minimum value of on resistance as measured over the specified analog signal range.
Source Leakage Current with the switch "OFF."
Channel Leakage Current with the switch "ON."
Analog Voltage on Terminals D, S.
"OFF" Switch Source Capacitance.
"OFF" Switch Drain Capacitance.
"ON" Switch Capacitance.
Delay between applying the digital control input and the output switching on.
Delay between applying the digital control input and the output switching off.
"OFF" time or "ON" time measured between the 90% points of both switches, when switching from one address state to another.
A measure of unwanted signal that is coupled through from one channel to another as a result of parasitic capacitance.
A measure of unwanted signal coupling through an "OFF" switch.
The frequency at which the output is attenuated by –3 dBs.
The frequency response of the "ON" switch.
The voltage drop across the "ON" switch seen on the On Response vs. Frequency plot as how many dBs the signal is away from 0 dB at very low frequencies.

ORDERING GUIDE

 V_{DD}

Model	Temperature Range	Package Description	Package Option	Branding Information*
ADG749BKS	-40°C to +85°C	SC70 (Plastic Surface Mount)	KS-6	SHB

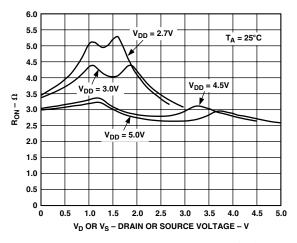
^{*}Brand = Brand on these packages is limited to three characters due to space constraints.

CAUTION -

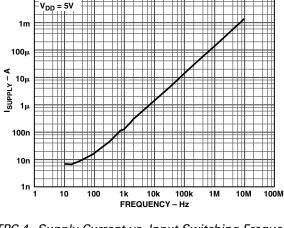
ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the ADG749 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high-energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



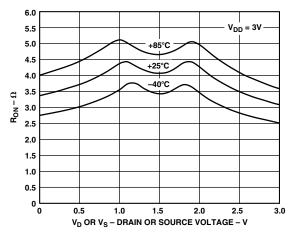
Typical Performance Characteristics—ADG749



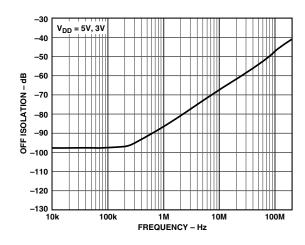
TPC 1. On Resistance as a Function of V_D (V_S) Single Supplies



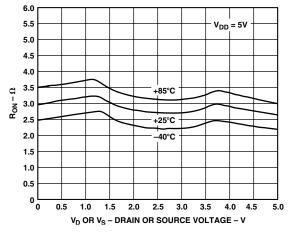
TPC 4. Supply Current vs. Input Switching Frequency



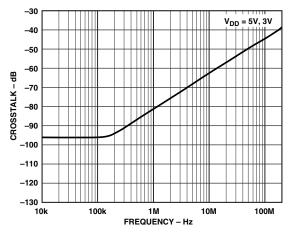
TPC 2. On Resistance as a Function of V_D (V_S) for Different Temperatures $V_{DD} = 3 \ V$



TPC 5. Off Isolation vs. Frequency



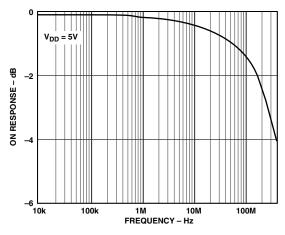
TPC 3. On Resistance as a Function of V_D (V_S) for Different Temperatures $V_{DD} = 5 \ V$



TPC 6. Crosstalk vs. Frequency

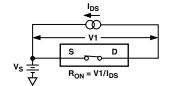
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ADG749

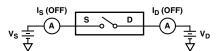


TPC 7. On Response vs. Frequency

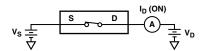
Test Circuits



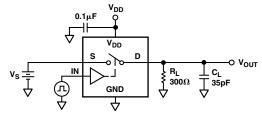
Test Circuit 1. On Resistance

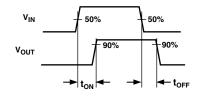


Test Circuit 2. Off Leakage

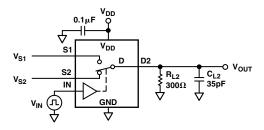


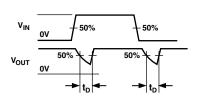
Test Circuit 3. On Leakage



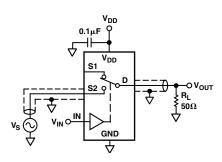


Test Circuit 4. Switching Times

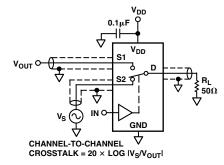




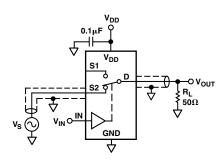
Test Circuit 5. Break-Before-Make Time Delay, t_D



Test Circuit 6. Off Isolation



Test Circuit 7. Channel-to-Channel Crosstalk



Test Circuit 8. Bandwidth

APPLICATIONS INFORMATION

The ADG749 belongs to Analog Devices' new family of CMOS switches. This series of general purpose switches have improved switching times, lower on resistance, higher bandwidths, low power consumption and low leakage currents.

ADG749 Supply Voltages

Functionality of the ADG749 extends from 1.8 V to 5.5 V single supply, which makes it ideal for battery powered instruments, where important design parameters are power efficiency and performance.

It is important to note that the supply voltage effects the input signal range, the on resistance and the switching times of the part. By taking a look at the typical performance characteristics and the specifications, the effects of the power supplies can be clearly seen.

For V_{DD} = 1.8 V operation, R_{ON} is typically 40 Ω over the temperature range.

On Response vs. Frequency

Figure 1 illustrates the parasitic components that affect the ac performance of CMOS switches (the switch is shown surrounded by a box). Additional external capacitances will further degrade some performance. These capacitances affect feedthrough, crosstalk and system bandwidth.

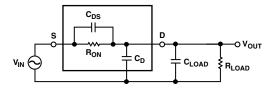


Figure 1. Switch Represented by Equivalent Parasitic Components

The transfer function that describes the equivalent diagram of the switch (Figure 1) is of the form (A)s shown below.

$$A(s) = R_T \left[\frac{s(R_{ON} \ C_{DS}) + 1}{s(R_T \ R_{ON} \ C_T) + 1} \right]$$

where:

$$R_T = R_{LOAD}/(R_{LOAD} + R_{ON})$$

$$C_T = C_{LOAD} + C_D + C_{DS}$$

The signal transfer characteristic is dependent on the switch channel capacitance, $C_{\rm DS}$. This capacitance creates a frequency zero in the numerator of the transfer function A(s). Because the switch on resistance is small, this zero usually occurs at high frequencies. The bandwidth is a function of the switch output capacitance combined with $C_{\rm DS}$ and the load capacitance. The frequency pole corresponding to these capacitances appears in the denominator of A(s).

The dominant effect of the output capacitance, C_D , causes the pole breakpoint frequency to occur first. Therefore, in order to maximize bandwidth a switch must have a low input and output capacitance and low on resistance. The On Response vs. Frequency plot for the ADG749 can be seen in TPC 7.

Off Isolation

Off isolation is a measure of the input signal coupled through an off switch to the switch output. The capacitance, C_{DS} , couples the input signal to the output load, when the switch is off as shown in Figure 2.

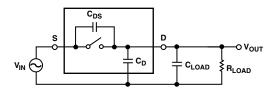


Figure 2. Off Isolation Is Affected by External Load Resistance and Capacitance

The larger the value of C_{DS} , larger values of feedthrough will be produced. The typical performance characteristic graph of TPC 5 illustrates the drop in off isolation as a function of frequency. From dc to roughly 200 kHz, the switch shows better than -95 dB isolation. Up to frequencies of 10 MHz, the off isolation remains better than -67 dB. As the frequency increases, more and more of the input signal is coupled through to the output. Off isolation can be maximized by choosing a switch with the smallest C_{DS} as possible. The values of load resistance and capacitance affect off isolation also, as they contribute to the coefficients of the poles and zeros in the transfer function of the switch when open.

$$A(s) = \left[\frac{s(R_{LOAD} \ C_{DS})}{s(R_{LOAD}) (C_{LOAD} + C_D + C_{DS}) + 1}\right]$$

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OUTLINE DIMENSIONS

Dimensions shown in inches and (mm).

6-Lead Plastic Surface Mount Package (SC70) (KS-6)

